

Nanocrystalline Diamond-Like Carbon Coatings Boost Field-Emission Efficiency of Silicon Nanowires

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INTRODUCTION & AIM

- ❖ **Field emission (FE)** involves electron tunneling under high electric fields and is essential for devices like flat-panel displays, X-ray sources, and electron microscopes.
- ❖ **Silicon Nanowires (SiNWs)** offer excellent FE enhancement due to their sharp tips and high aspect ratio but suffer from oxidation and emission instability.
- ❖ **Nanocrystalline Diamond-Like Carbon (nc-DLC)** coatings add chemical stability, high sp^3 content, and negative electron affinity (NEA), improving emission performance.
- ❖ This study combines **SiNWs with nc-DLC coatings** to enhance FE efficiency.
- ❖ We investigate how the **coating time (or coating layer's thickness)** influence the overall hybrid material (**SiNW/nc-DLC**) structure and field emission behavior.

METHOD

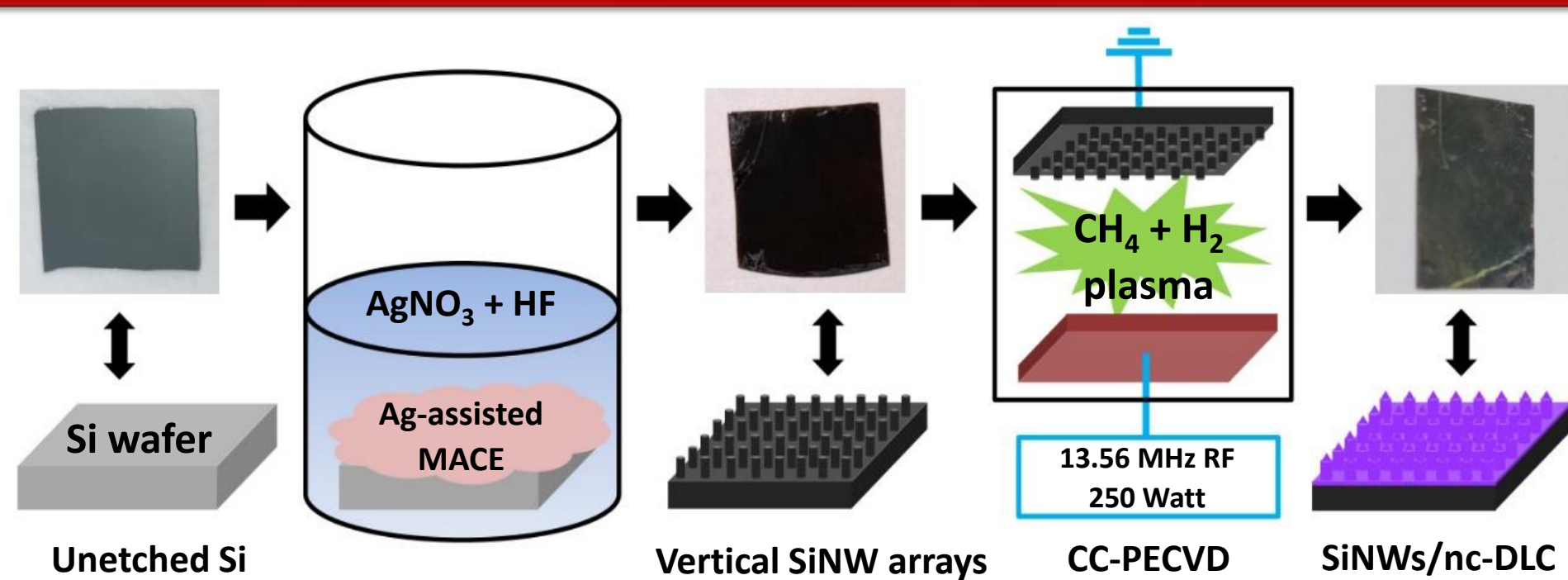
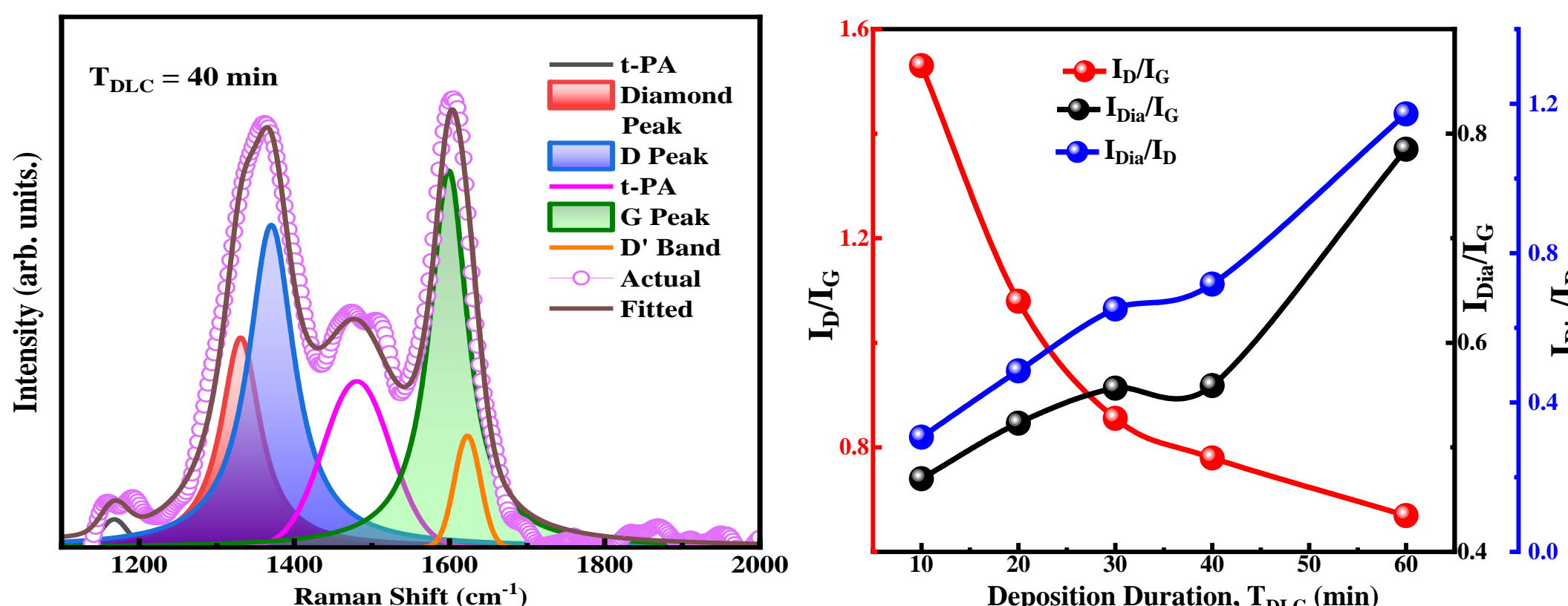


Fig. 1: Schematic of the sequential steps forming SiNW/nc-DLC hybrid structures

- ❑ **SiNW Fabrication:** via metal assisted chemical etching (MACE) from crystalline Si wafers
- ❑ **nc-DLC Deposition:** in capacitively coupled plasma enhanced chemical vapour (CC-PECVD) deposition using CH_4/H_2 gas mixture ratio 1:1, 450 °C, 250 W RF power, 4 Torr pressure
- ❑ **nc-DLC Coating Time (T_{DLC}) Variation:** 10–60 min
- ❑ **Characterization:** Raman, XPS, SEM, TEM, FE characteristics

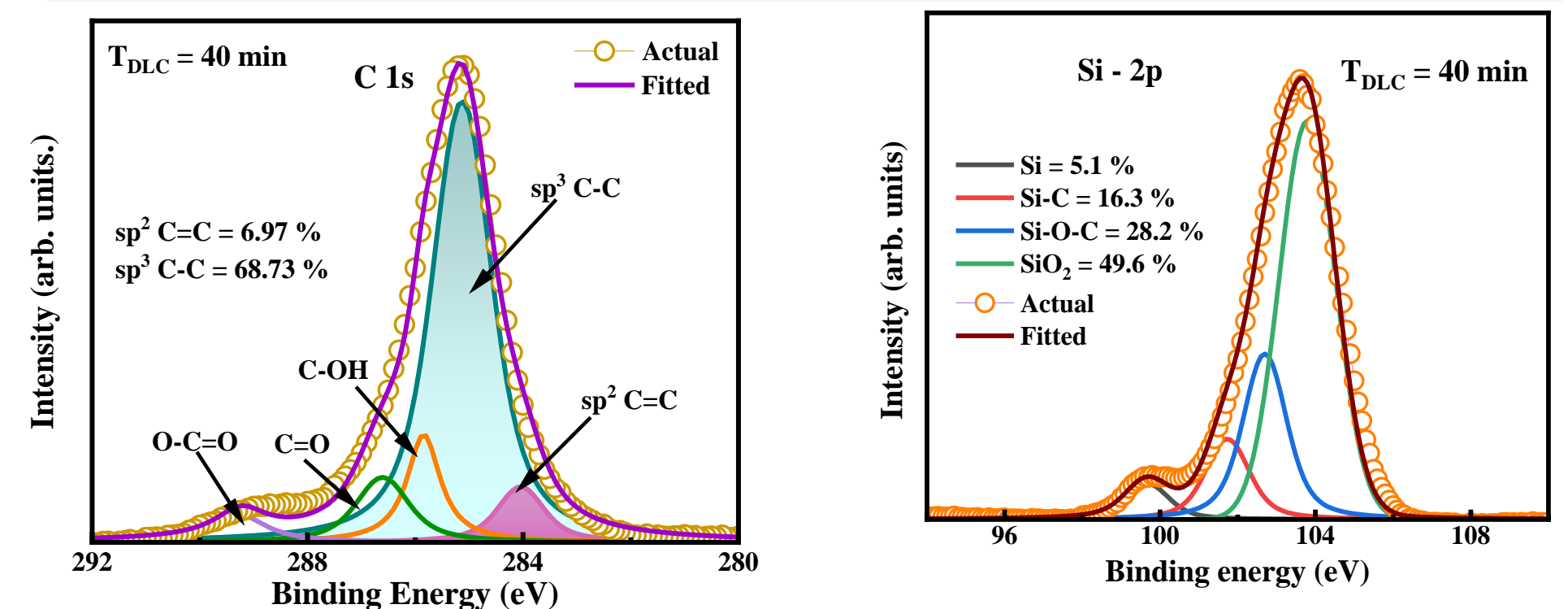
RESULTS & DISCUSSION

Raman Spectroscopy of nc-DLC layer coated on SiNWs



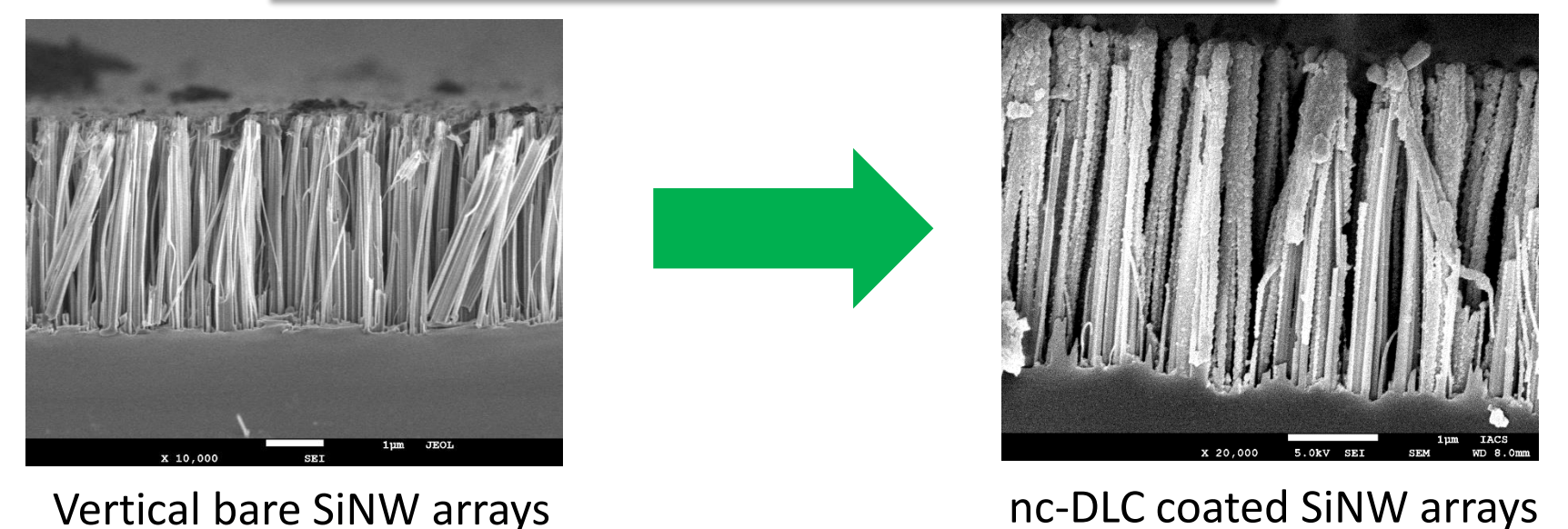
- ❖ At $T_{DLC} = 60$ min, Min $I_D/I_G = 0.67$, max $I_{Dia}/I_D = 1.17$ and max $I_{Dia}/I_G = 0.79$
- ❖ Min I_D/I_G corresponds to lowest disorder
- ❖ Higher I_{Dia}/I_D and I_{Dia}/I_G indicates more diamond-like crystalline orientation (sp^3 C-C) relative to the disorderness and graphitic (sp^2 C=C).
- ❖ At $T_{DLC} = 40$ min, a moderate nano-crystallinity is obtained.

X-ray Photoelectron Spectroscopy of nc-DLC layer coated on SiNWs

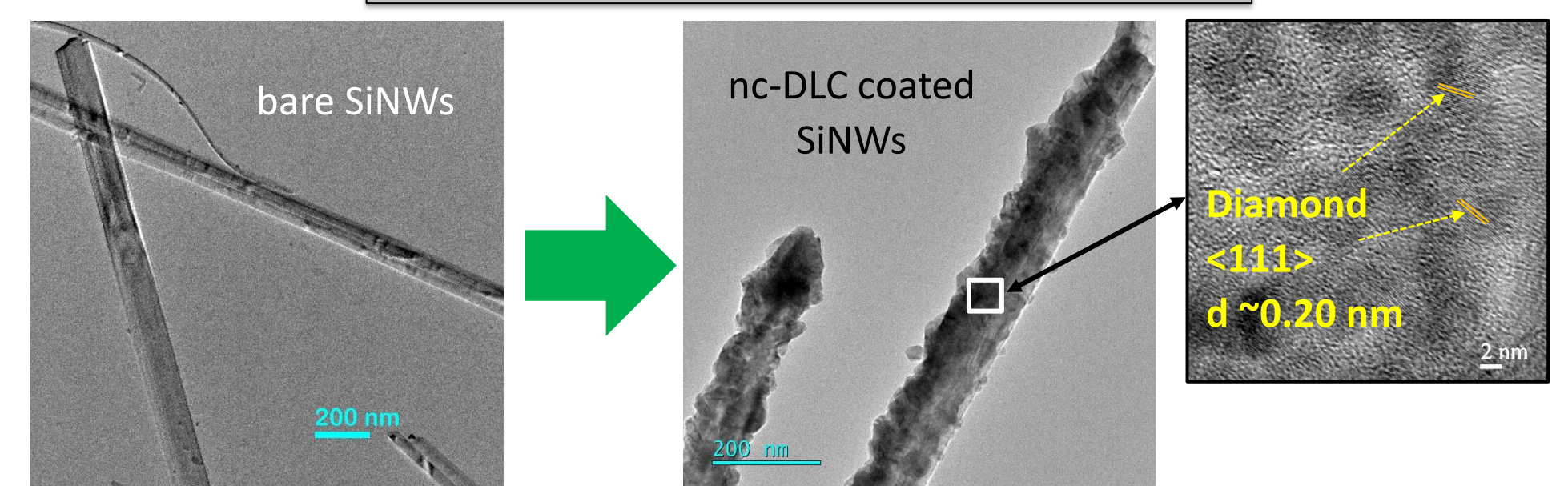


- At $T_{DLC} = 40$ mins, C 1s XPS shows sp^3 C-C content = 68.73%
- From Si-2p, the Si-C = 16.3%, which is the highest in the series.

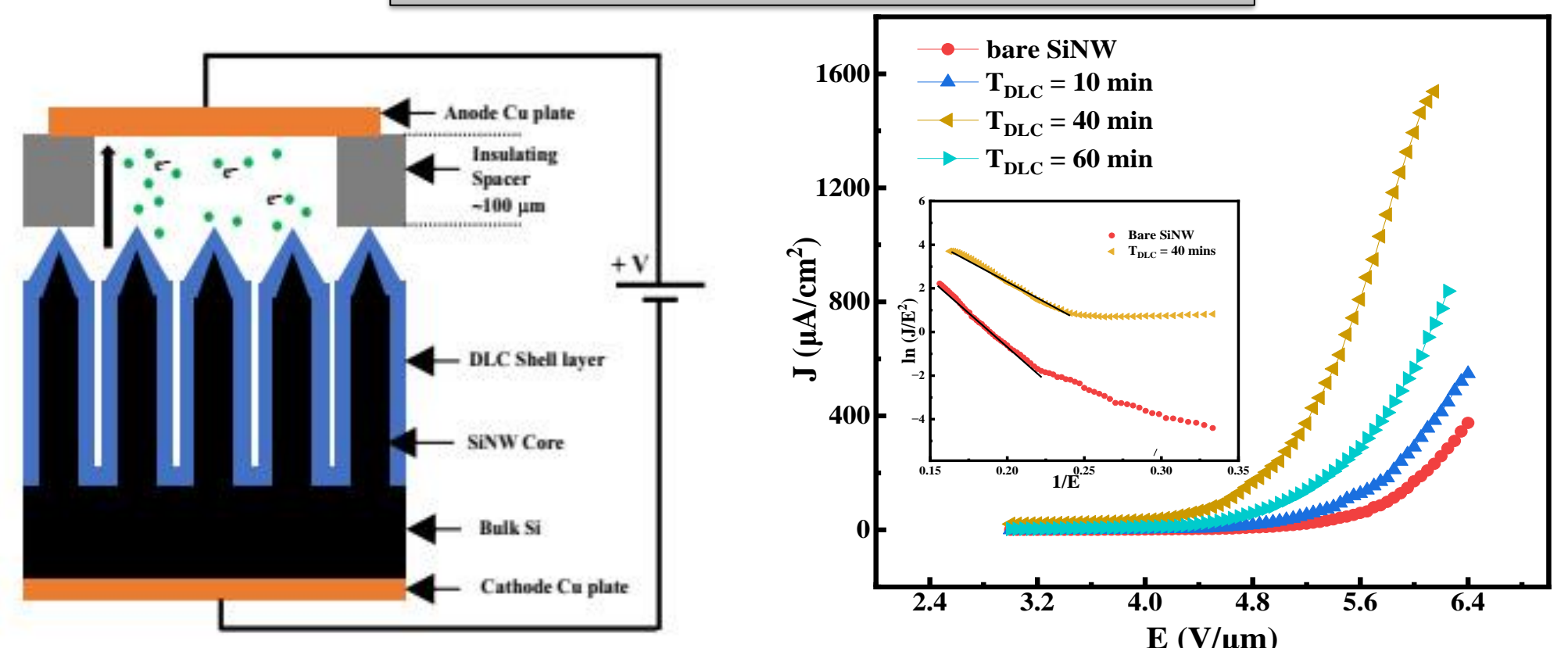
Cross-Scanning Electron Microscopy



Transmission Electron Microscopy



Field Emission Characteristics



CONCLUSION

- ❑ SiNW/nc-DLC hybrids show significantly enhanced FE performance compared to bare SiNWs, Increasing sp^3 content and nanocrystallinity with T_{DLC} , lowers the surface potential barrier and improves electron tunneling
- ❑ **Optimal DLC coating time ($T_{DLC} = 40$ min) yields the best performance:** Turn-on field (E_{ON}) reduced from ~ 5.80 V/ μm (bare) to 4.60 V/ μm , Emission current density (J_e) peaks at 1393.46 $\mu A/cm^2$, Field enhancement factor (β) rises to 1676.01
- ❑ **Over-coating ($T_{DLC} = 60$ min) increases DLC thickness, leading to reduced emission** ($E_{ON} = 5.05$ V/ μm , $\beta = 1518.34$), highlighting the importance of thickness optimization.
- ❑ **Enhanced FE is attributed to:** sp^3 -rich nanocrystalline domains lowering the barrier grain boundaries and defects acting as emission sites.
- ❑ **Excessively thick coatings**, however, reduce β by increasing emitter tip radius and limiting electron escape